

Search Notes

Application/Control No.

10/615,287

Examiner

H.Jey Tsai

Applicant(s)/Patent under
Reexamination

PAREKH ET AL.

Art Unit

2812

SEARCHED

Class	Subclass	Date	Examiner
438	238, 253- 256, 381, 3, 240	2/1/2005	J
438	396-399	2/1/2005	J

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	253	2/1/2005	J

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR